

## Supplementary information

### **Scalable synthesis of Bi<sub>2</sub>O<sub>2</sub>S nanoplates with large piezoelectric potential induced by built-in electric field in [Bi<sub>2</sub>O<sub>2</sub>]<sup>2+</sup> layer for degradation of organic dyes**

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## Experimental section

### *S1. Chemicals*

Bismuth nitrate ( $\text{Bi}(\text{NO}_3)_3 \cdot 5\text{H}_2\text{O}$ , Aladdin Reagent Shanghai Co., Ltd.), sodium hydroxide (NaOH, Tianjin Xinbote Chemical Co., Ltd.), sublimated sulfur (S, Tianjin Best Chemical Co., Ltd.), precipitated sulfur (S, Tianjin Best Chemical Co., Ltd.), thioacetamide ( $\text{C}_2\text{H}_5\text{NS}$ , Aladdin Reagent Shanghai Co., Ltd.), and thiourea ( $\text{CH}_4\text{N}_2\text{S}$ , Aladdin Reagent Shanghai Co., Ltd.) were all commercially available analytically pure reagents in the experiment.

### *S2. Synthesis of $\text{Bi}_2\text{O}_2\text{S}$ nanosheets*

$\text{Bi}_2\text{O}_2\text{S}$  was synthesized via a low-heating solid-state chemical method. 4 mmol  $\text{Bi}(\text{NO}_3)_3 \cdot 5\text{H}_2\text{O}$  and 40 mmol NaOH were ground into powder, then the two compounds were mixed and ground until the reaction system turned yellow. 2 mmol of thiourea was added and ground for about 30 min until the reaction system turned dark red. The resulting mixture was sealed and placed in a conical flask, then placed in a water bath at  $80^\circ\text{C}$  for 12 h. Finally, the mixture was filtered and washed with distilled water, and the product was collected after drying and labeled as "BOS-S".

Other samples were fabricated with the same procedure except for the thiourea was replaced by thioacetamide, precipitated sulfur and sublimated sulfur, the corresponding products were labeled as "BOS-T", "BOS-C" and "BOS-H", respectively.

### *S3. Characterization of piezocatalysts*

The morphology was observed by field emission scanning electron microscopy (FESEM, Hitachi S-4800H) using an accelerating voltage of 5 kV, transmission electron microscopy (TEM, Hitachi H-600) using an accelerating voltage of 120 kV, and high-resolution transmission electron microscopy (HR-TEM, JEOL JEM-2010F) using an accelerating voltage of 200 kV. The element component was measured by the energy disperse X-ray spectrum (EDS, EDAXTLS). The crystallographic information of samples was investigated by performing X-ray powder diffraction (XRD) characterization using a D8 Advance X-ray diffractometer with non-monochromated

Cu K $\alpha$  X-ray source ( $\lambda=1.054056 \text{ \AA}$ ) in an operating voltage of 40 kV and a beam current of 40 mA. X-ray photoelectron spectroscopy (XPS) (Thermo Fisher Scientific ESCALAB250Xi) employing Al K $\alpha$  (1486.6 eV) was taken to identify the surface components and valence states of products. Hydroxyl ( $\cdot\text{OH}$ ) and super-oxide ( $\cdot\text{O}_2^-$ ) radicals were measured on electron spin resonance (ESR) spectrometer (MEX-nano, Bruker) via 5, 5-dimethyl-1-pyrroline N-oxide (DMPO). The optical properties and energy band structure of the samples were tested by UV-vis Diffuse Reflectance Spectroscopy (UV-vis, DRS). The piezoelectric properties were determined by piezo-response force microscopy (PFM, Bruker, ICON). Piezoelectric constants (d33) were calculated from the amplitude-voltage butterfly loops.

#### *S4. Piezocatalytic performances measurements*

A customized piezoelectric ultrasonic machine at 100 W, 40 kHz was used as the vibrational excitation source. The simulated pollutants chosen for this experiment were rhodamine B (RhB), tetracycline hydrochloride (TCH), methylene blue (MB), and methyl orange (MO). The volume of organic pollutants was 100 mL, the concentration of RhB, MB and MO were 5 mg L<sup>-1</sup>, the concentration of TCH was 10 mg L<sup>-1</sup>, and the amount of catalyst was 30 mg. The specific operation steps are as follows: the catalyst was dispersed in RhB (or TCH, MB, MO) solution, the system was stirred in the dark for 30 min before ultrasound to reach the physical adsorption-desorption equilibrium. In order to avoid the influence of high temperature on the piezoelectric catalytic performance, the water should be changed every 10 min. 4 mL of the pollutants were taken at fixed interval and centrifuged at high speed (8000 r/min, 5 min) to remove catalyst, the absorbance of the supernatant should be determined by UV-vis absorption photometer.

In addition, various scavengers were employed to elucidate the roles of different reactive species in the degradation process. p-Benzoquinone (BQ), isopropanol (IPA), triethanolamine (TEOA) and silver nitrate (AgNO<sub>3</sub>) were used as the trapping agents for  $\cdot\text{O}_2^-$  radicals,  $\cdot\text{OH}$  radicals,  $\text{h}^+$  and  $\text{e}^-$ , respectively. At the end of the dark reaction experiment, 10 mL of the radical trapping agent with the concentration of 1 mmol L<sup>-1</sup> was added into the catalytic reaction system, then the performance test was carried out.

### S5. The calculation of piezoelectric coefficient ( $d_{33}$ )

The  $d_{33}$  values could be acquired through calculating the corresponding slope of the Displacement-Voltage curve according to Equation:

$$d_{33} = (A - A_0) / (V - V_0)$$

Where  $V$  and  $A$  represent the applied voltage and amplitude respectively;  $V_0$  and  $A_0$  are the intersection point of the amplitude butterfly loop curve.

## Supplementary Figs and Tables

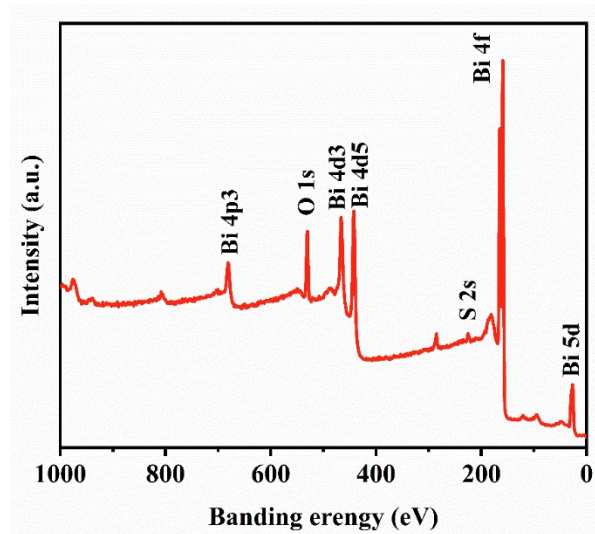


Fig. S1 XPS survey spectra of BOS-S.

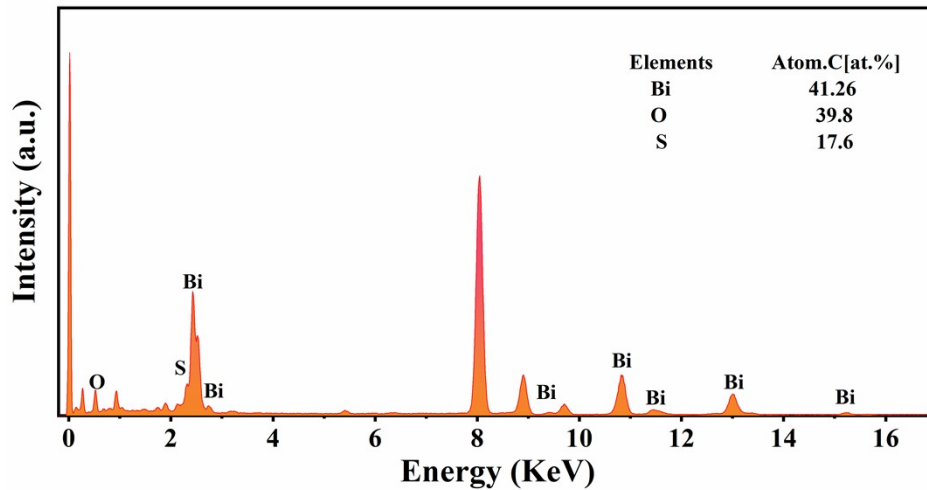


Fig. S2 EDS spectrum of BOS-S nanorods.

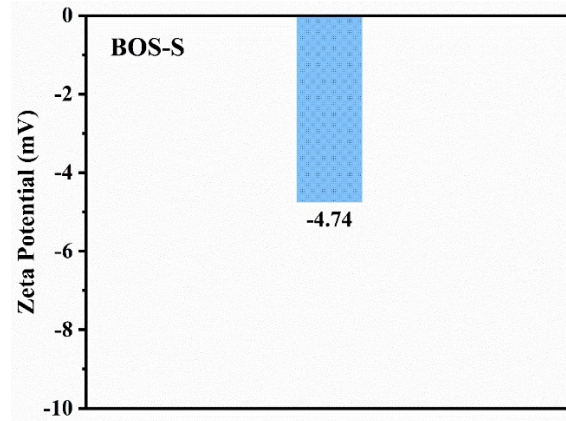


Fig. S3 Zeta potential of BOS-S.

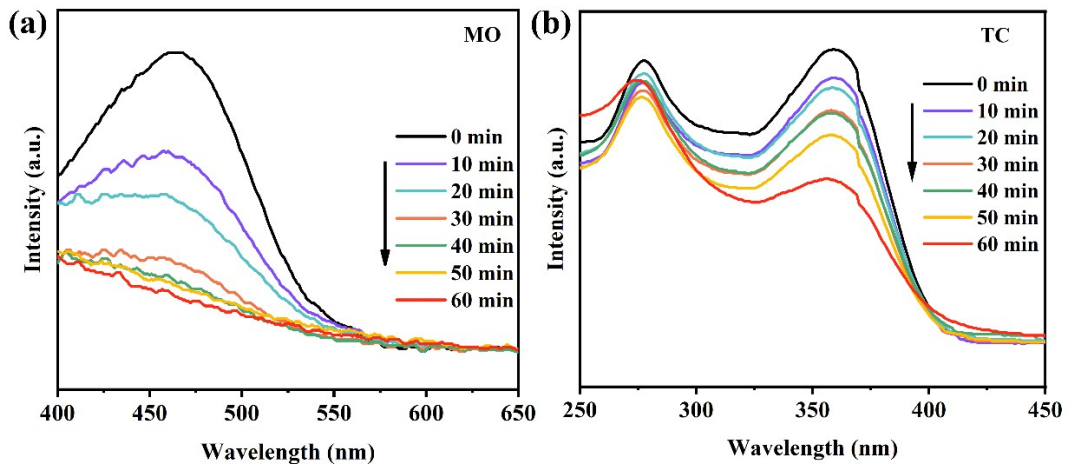


Fig. S4 UV-vis spectral change of (a) MO and (b) TC that piezoelectricity degraded by BOS-S.

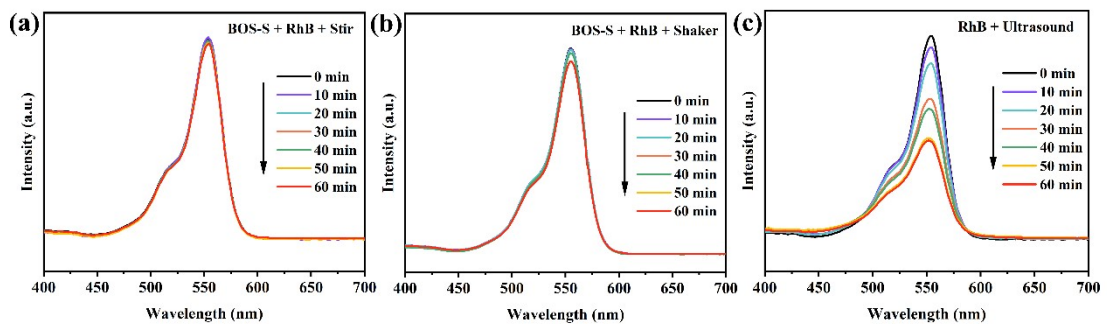
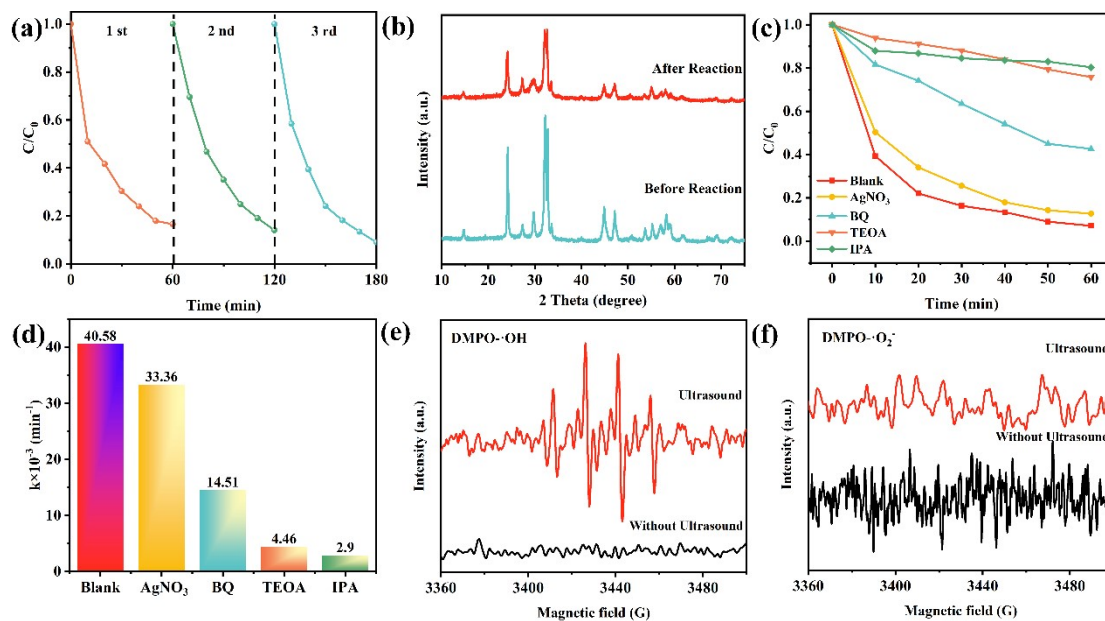
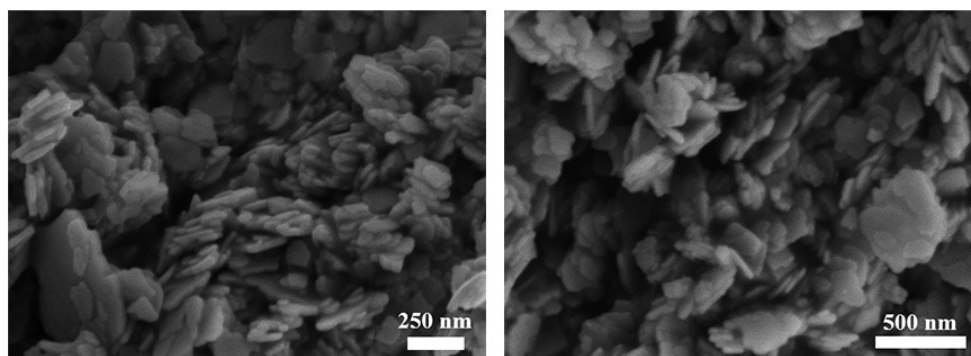


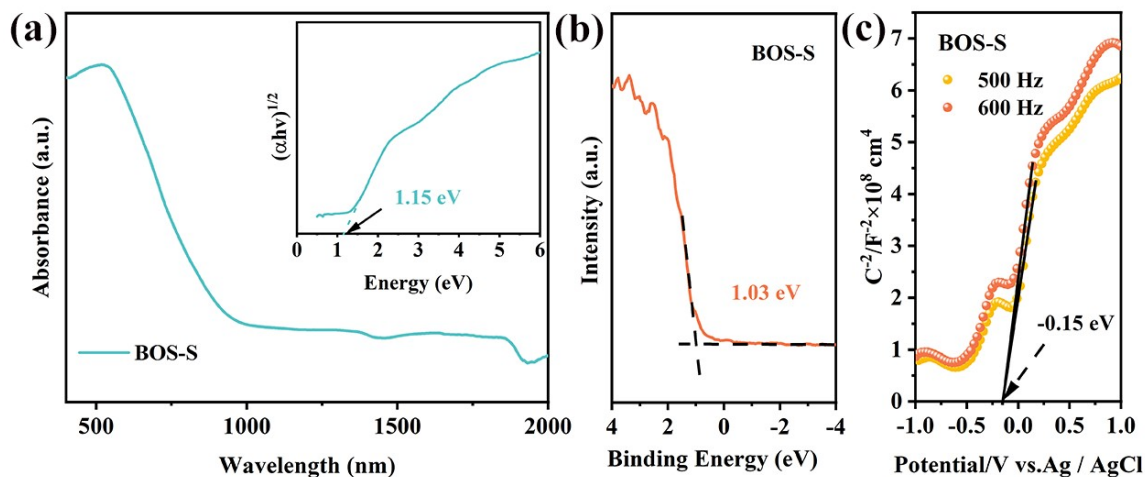
Fig. S5 (a) UV-vis spectral change of RhB under different conditions: (a) catalyst, dye and agitation, (b) catalyst, dye and shaker, (c) dye and ultrasound.



**Fig. S6** (a) Recycling measurements and (b) the XRD pattern of before and after piezocatalytic of RhB for BOS-S, (c) piezoelectric-catalyzed degradation of RhB dye by BOS-S in the presence of different radical scavengers, (d) kinetic rate constants of the reaction of BOS-S with different radical scavengers, (e) DMPO·OH ESR spectra of BOS-S in aqueous dispersions, (f) DMPO·O<sub>2</sub>· ESR spectra of BOS-S in MeOH dispersions



**Fig. S7.** The SEM of the BOS-S after cycling.



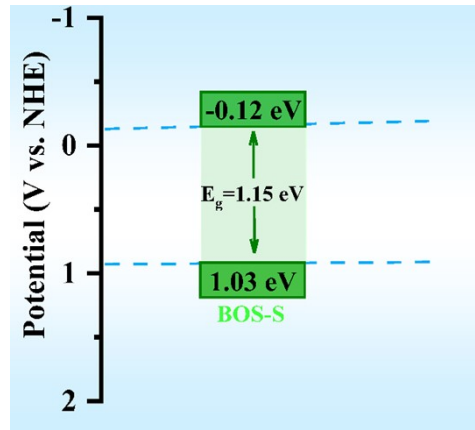
**Fig. S8** (a) UV-visible diffuse reflection spectrum (the insert is the relationship between  $(\alpha hv)^{1/2}$  and light energy ( $hv$ )), (b) XPS valence band spectrum and (c) Mott-Schottky curve of BOS-S sample.

The BOS-S sample presents a wide light absorption range from ultraviolet to visible then to near-infrared in Fig. S8a. The band-gap width of BOS-S is 1.15 eV through the fitting calculation of equation (1-1), in which BOS-S is an indirect band-gap semiconductor material, and the  $n$  value is  $1/2$ .<sup>1</sup> The XPS valence band of Fig. S8b shows a valence band potential ( $E_{VB}$ ) of BOS-S is 1.03 eV. The conduction band potential of BOS-S is calculated to be -0.12 eV according to equation (1-2). To further determine the energy band structure of BOS-S, Mott-Schottky curve (MS) is obtained. A positive slope of the curve is observed from Fig. S8c, indicating that BOS-S is an n-type semiconductor.<sup>2,3</sup> The intercept of the MS curve on the X-axis is the flat-band potential ( $E_{fb}$ ), the  $E_{fb}$  of BOS-S is -0.15 V (vs. Ag/AgCl). The  $E_{fb}$  ratio conduction band potential ( $E_{CB}$ ) for n-type semiconductors is corrected (0.20 V), and the  $E_{CB}$  for calculating BOS-S is -0.35 V vs. Ag/AgCl. Through equation (1-3) conversion, the  $E_{CB}$  of BOS-S is -0.15 eV (vs. NHE), which is basically consistent with the calculation result of XPS valence band.

$$(\alpha hv)^n = k(hv - E_g) \quad (1-1)$$

$$E_{CB} = E_{VB} - E_g \quad (1-2)$$

$$E_{NHE} = E_{Ag/AgCl} + 0.197 \text{ V} \quad (1-3)$$



**Fig. S9** The energy band gap structure of BOS-S.



**Table S1.** Comparison of the piezoelectric coefficient ( $d_{33}$ ) of  $\text{Bi}_2\text{O}_2\text{S}$  with those of reported piezoelectric materials.

<b>Piezocatalysts</b>	<b><math>d_{33}</math> (pm V<sup>-1</sup>)</b>	<b>reference</b>
$\text{Bi}_2\text{O}_2\text{S}$	29	This work
$\text{MoSe}_2/\text{PVDF}$	6.5	[4]
$\text{BaTiO}_3/\text{TCN}$	20.2	[5]
P-KNbO <sub>3</sub>	10	[6]
$\text{Sn}_{0.97}\text{Ag}_{0.03}\text{S}_2$	4.5	[7]
$\text{Bi}_2\text{Fe}_4\text{O}_9$	4	[8]
$\text{MoS}_2/\text{Bi}_2\text{S}_3$	2.5	[9]
BFO MPL( $\text{BaTiO}_3$ )	18.6	[10]
$\text{BiFeO}_3@\text{CdS}$	4	[11]
$\text{In}_2\text{Se}_3$	1.6	[12]
$\text{BaTiO}_3\text{NFs}$	11.1	[13]
$\text{MoS}_2/\text{BP}$	14.3	[14]

**Table S2.** Comparison piezocatalytic degradation of organic pollutants performances over catalysts previously reported with this work.

<b>Piezocatalysts</b>	<b>Dyes species and concentration</b>	<b>Conditions</b>	<b>Degradation efficiency</b>	<b>Reference</b>
Bi <sub>2</sub> O <sub>2</sub> S	MB, 5 mg/L RhB, 5 mg/L	100 W, 40 kHz	92.8%, 60 min. 97.7%, 60 min.	This work
Ba(Zr <sub>0.05</sub> Ti <sub>0.95</sub> )O <sub>3</sub>	MB, 5 mg/L RhB, 5 mg/L	180 W, 40 kHz	90%, 90 min. 70%, 90 min.	[15]
Au–ZnO	RhB, 5 mg/L	80 W, 40 kHz	88%, 75 min.	[16]
NaNbO <sub>3</sub>	RhB, 5 mg/L	50 W, 40 kHz	61.9%, 100 min.	[17]
ZIF-8	RhB, 5 mg/L	180 W, 40 kHz	94%, 150 min.	[18]
BiVO <sub>4</sub>	MB, 5 mg/L	150 W, 40 kHz	86.4%, 40 min.	[19]
Ag/LN-PVDF	RhB, 5 mg/L MB, 5 mg/L	70 W, 40 kHz	80%, 120 min. 89%, 120 min.	[20]
Pb(Zr <sub>0.52</sub> Ti <sub>0.48</sub> )O <sub>3</sub>	MB, 5 mg/L	70 W, 40 kHz	84%, 120 min.	[21]
CuS/ZnO	MB, 10 mg/L	150 W, 40 kHz	94.7%, 40 min.	[22]
BaTiO <sub>3</sub>	MB, 5 mg/L	120 W, 40 kHz	77.0%, 60 min.	[23]

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